



Computing Platform Service Partner

GCS-1100I

Environment Test Report

Report NO: 10I020011

Issued by: **Rex Chang** / **08/13/2010**

Test Engineer Date

Reviewed by: **Jansin Lee** / **08/13/2010**

Sr. Manager Date

Test item list

1. <i>Test item list</i> -----	2
2. <i>Configuration of EUT</i> -----	3
2. <i>Temperature rise test</i> -----	4
3. <i>Temperature cycle operation test</i> -----	8
4. <i>High temperature storage test</i> -----	9
5. <i>Low temperature storage test</i> -----	10
6. <i>Humidity test</i> -----	11
7. <i>Cold start and hot start test</i> -----	12

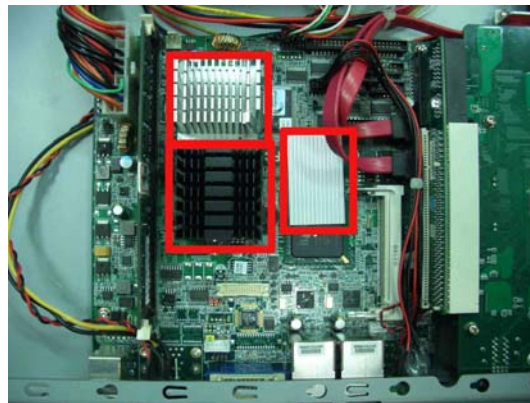
Testing Result

Num	Test item list	Result	Remark
1	Temperature rise test	Pass	
2	Temperature cycle operation test	Pass	
3	High temperature storage test	Pass	
4	Low temperature storage test	Pass	
5	Temperature variation operation test	Pass	
6	Cold start and hot start test	Pass	

Configuration of EUT

Num	Item	Spec
1.	Rack Mount Chassis:	GCS-1100I
	1. Main Board	AAEON EMB-9459T Rev. B1.0 (BIOS Ver: 1100i 0.1)
	2. CPU	Intel Atom N270 / 1.6GHz
	3. Memory	DSL 1GB * 1 / DDR2 533 / ELPIDA E5108AGBG-6E-E
	4. 2.5" SATA SSD	Transcend TS32GSSD25S-S / 32GB
	5. Test Software	Windows XP / Run PassMark Burn In Test 4.0 Pro
	6. DC Power	CSC MPD-807H
2.	Power Adapter	FSP FSP084-DMAA1

Heat Sink



Temperature rise test

Test Date: 08-12-2010

Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

Test Standard: Reference EN 61131-2(94), UL508 (94)

Temperature Measurement:

40 Channel Thermal Recorder:
YOKOGAWA Inc,
Model: DA100-13-1D
Date of Calibration: 12/08/09
Serial Number: 12A323190

Test Condition:

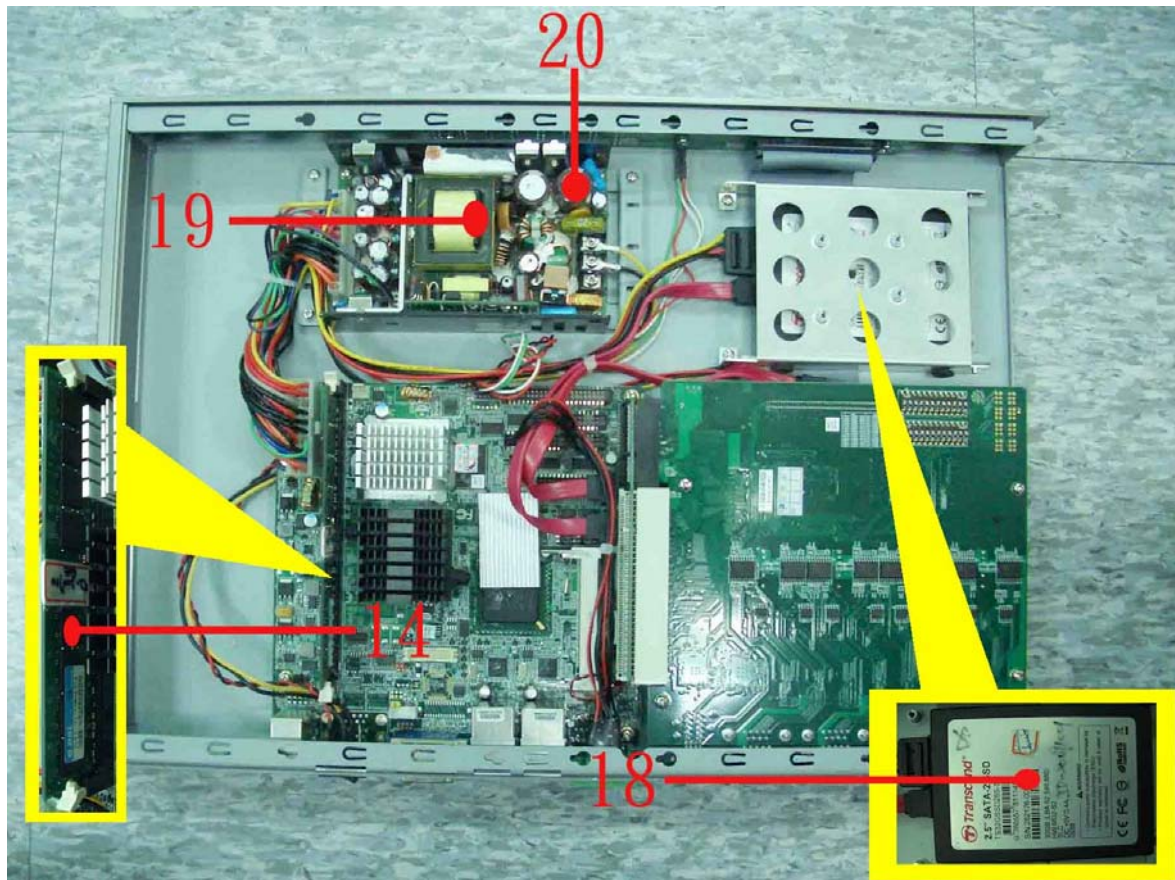
Ambient temperature: 45°C
Continuous running till thermal stability (within less than 1°C)

Test Software:

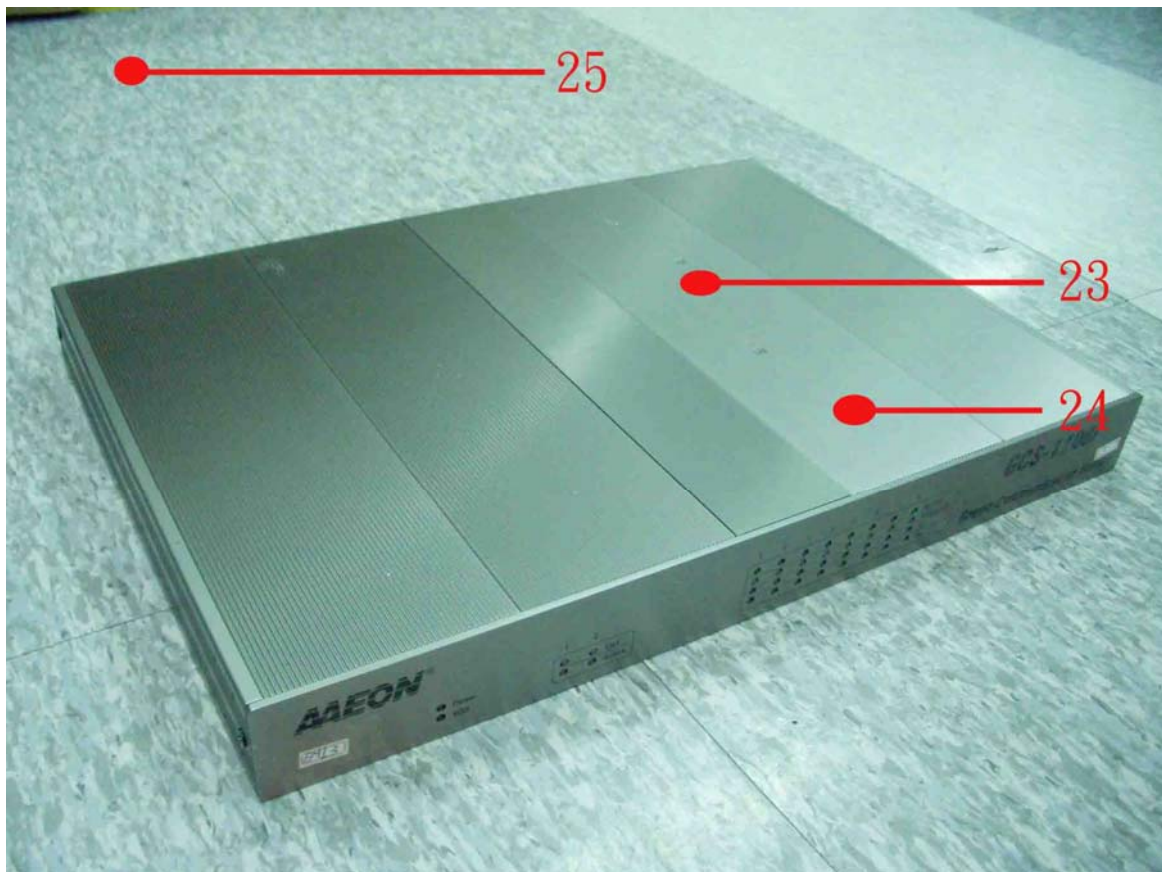
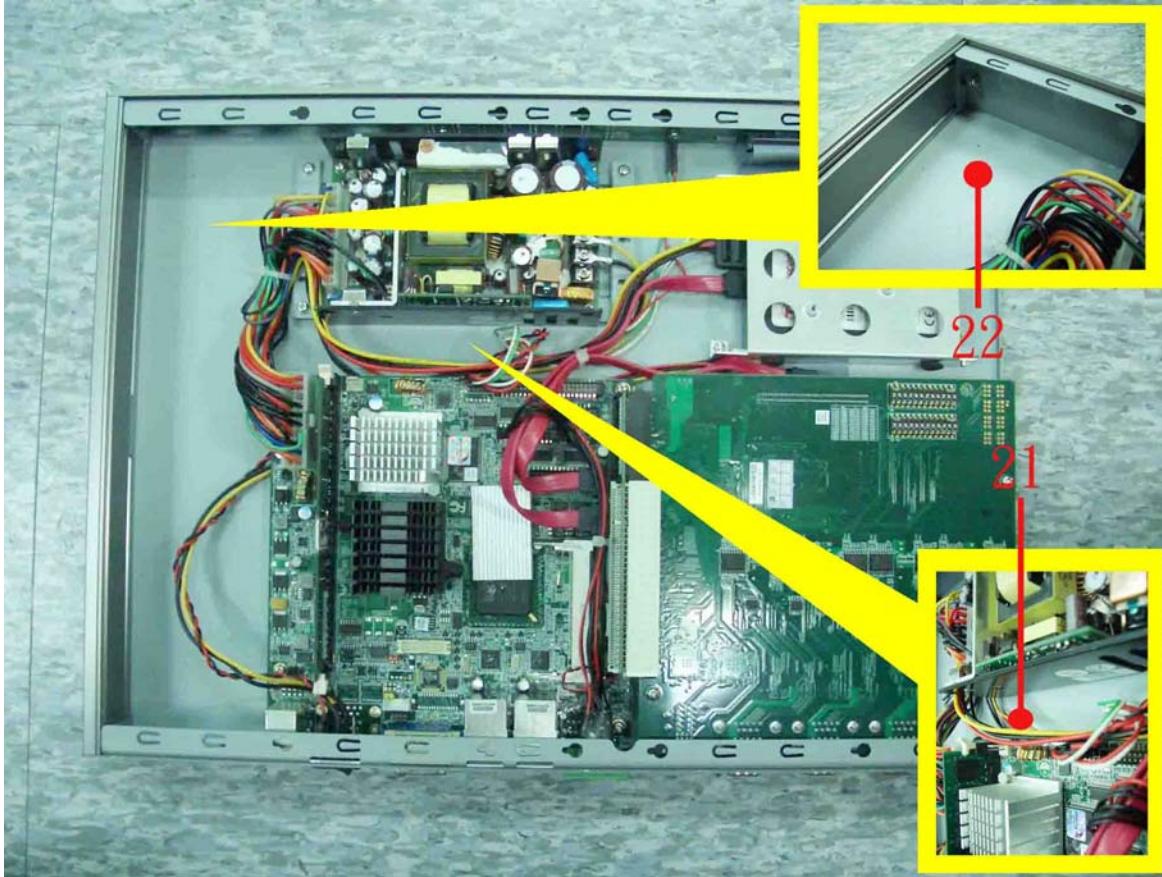
Windows XP / Run PassMark Burn In Test 4.0 Pro

Terminal Recorder:

Measuring Thermal Couple Position :



Temperature rise test



Temperature rise test

Thermal profile data:

GCS-1100I

Point	Temp. Stage(°C)	Spec	45	25
EMB-9459T				
01. U38 - (TF) Intel CPU.Diamondville.N270.1.6GHz/FSB		90	88.9	68.9
02. U30 - (TF) Chipset.Intel.QG82945GSE SLB2R		105	85.2	65.2
03. U28 - (TF) Chipset ICH7M.Intel.NH82801GBM SL8YB		99	95.0	75.0
04. U33 - (TF) CLOCK GENERATOR.ICS.ICS954226AGLF		115	88.5	68.5
05. U35 - (TF) Super I/O.ITE.IT8712F/KX-L		95	79.5	59.5
06. U10 - (TF) DVI Transmitter.CHRONTEL.CH7307C-DEF		110	70.4	50.4
07. U18 - (TF) Ethernet Chip.REALTEK.RTL8111C-VB-GR		95	71.2	51.2
08. U17 - (TF) Ethernet Chip.REALTEK.RTL8111C-VB-GR		95	71.2	51.2
09. U52 - (TF) Synchronous Buck PWM.DC-DC Controller.Fiti.FP6321ASOPTR		125	70.9	50.9
10. L66 - (TF) Coil. GOTREND.C4452P-08A09YDPS		110	73.5	53.5
11. Q69 - (TF) PWR.DPAK. N-Channel MOSFET.ST.STD17NF03LT4		100	70.3	50.3
12. L58 - (TF) COIL.GOTREND.GSTC063P-1R5MN		125	73.6	53.6
13. U53 - (TF) DDR1/2/3 Memory Power Supply.Semtech.SC488MLTRT		125	74.2	54.2
14. Memory		95	75.1	55.1
PER-T167				
15. U100- (TF) Octal-UARTs.SystemBase.SB16C1058PCI		85	58.3	38.3
16. U3 - (TF) PCI-express.Gigabit Ethernet Chip.REALTEK.RTL8111C-VB-GR		85	62.4	42.4
17. U1 - (TF) PCI-express.Gigabit Ethernet Chip.REALTEK.RTL8111C-VB-GR		85	62.8	42.8
18. SATA SSD Surface		70	60.2	40.2
Power Supply				
19. T1		110	66.8	46.8
20. C3		105	60.7	40.7
21. Control Box Inside Air Temperature - 1 (Power Temp. Ambient)		N/A	61.3	41.3
22. Control Box Inside Air Temperature - 2		N/A	53.4	33.4
23. Control Box External Surface - 1		N/A	55.1	35.1
24. Control Box External Surface - 2		N/A	54.4	34.4
25. Chamber Air Temperature		N/A	44.9	24.9
Any Tm value showed in red words which meaning the value over the Tc degree C of this device specification.				

Temperature rise test

Temperature Measurement Table:

Location	TA=45.0°C	Temp. Rise (Thermal Couple)	SpeedFan 4.31 (Read from BIOS)
CPU		88.7°C	80.0°C
System Temp. 1 (South Bridge)		95.0°C	84.0°C
System Temp. 2		N/A	70.0°C

Sample Configuration & Quantity Under Test:

Quantity: 1 (GCS-1100I)

Test Result:

No problem was found during the temperature rise operation test.

Temperature cycle test

Test Date: 07-30-2010 ~ 08-02-2010

Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

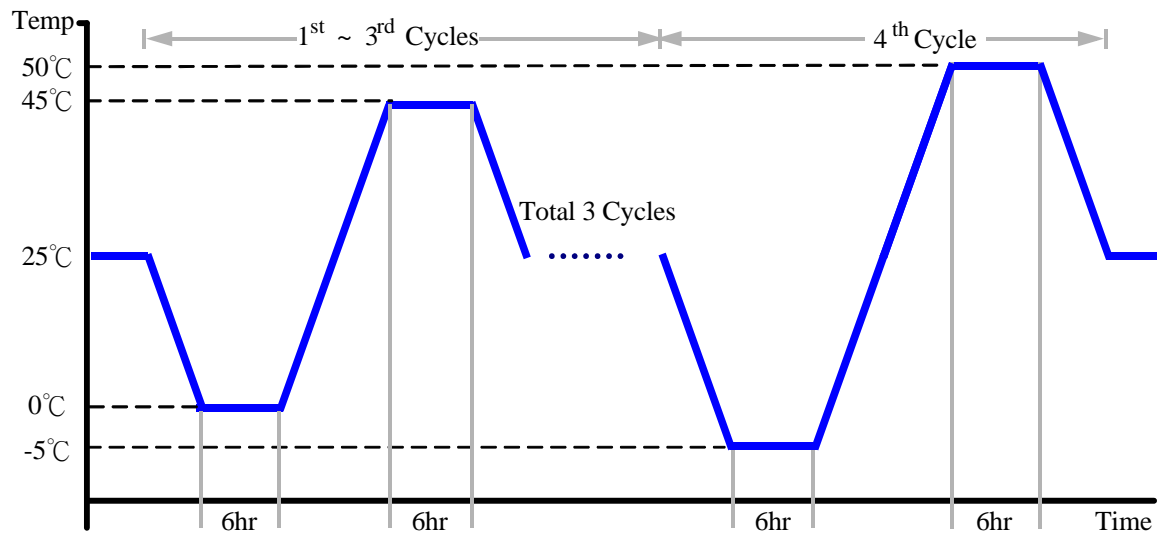
Test Standard: Reference IEC68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4L+-100
Date of Calibration: 05/06/10
Serial Number: 1241

Test Condition:

1. Test Low Temperature: 0°C (1~3 cycles)
-5°C (4th cycle)
2. Test High Temperature: 45°C (1~3 cycles)
50°C (4th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (GCS-1100I)

Test Result:

No problem was found during the temperature operation cycle test.

Test Date: 08-09~11-2010

Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

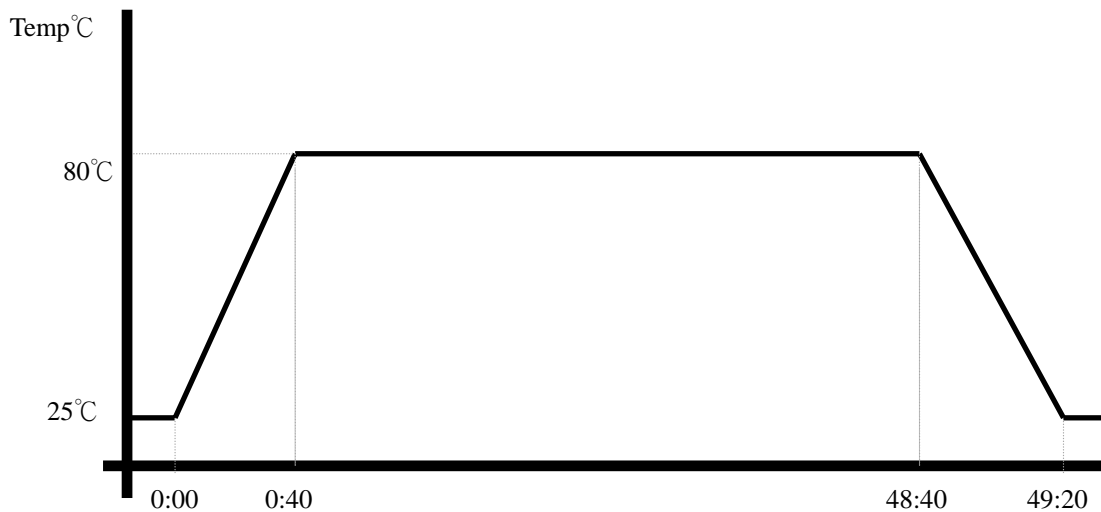
Model: THS-D4L+-100

Date of Calibration: 05/06/10

Serial Number: 1241

Testing Item:

1. Test Temperature: 80°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (GCS-1100I)

Test Result:

No problem was found after the high temperature storage test.

Test Date: 08-04~06-2010

Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-1 Testing procedures
Test Ab: Cold Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.

Model: THS-D4L+-100

Date of Calibration: 05/06/10

Serial Number: 1241

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (GCS-1100I)

Test Result:

No problem was found after the low temperature storage test.

Test Date: 08-06~09-2010

Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

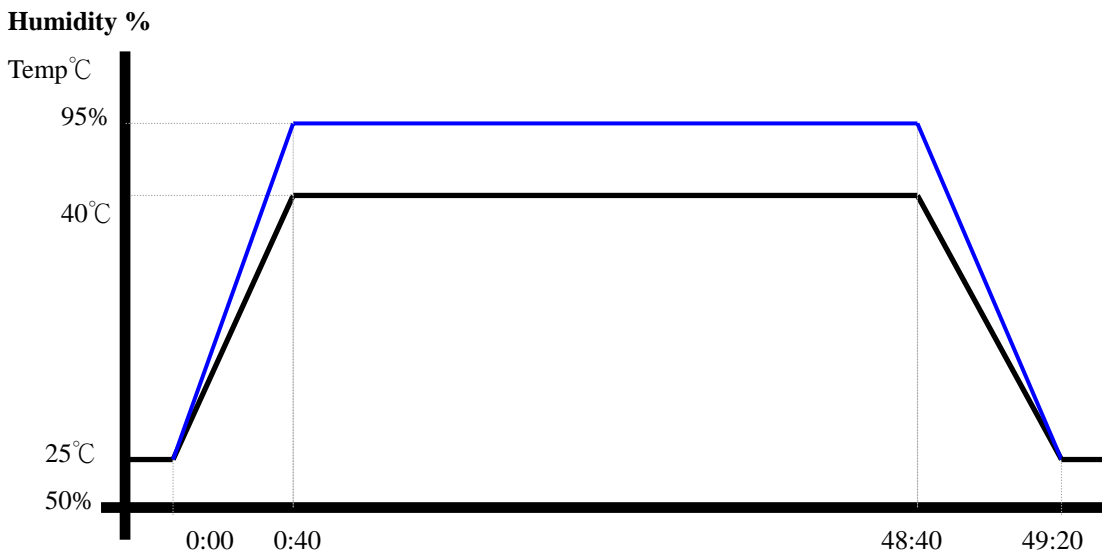
Model: THS-D4L+-100

Date of Calibration: 05/06/10

Serial Number: 1241

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (GCS-1100I)

Test Result:

No problem was found after the humidity storage test.

Cold start and hot start test

Test Date: 08-02~03-2010

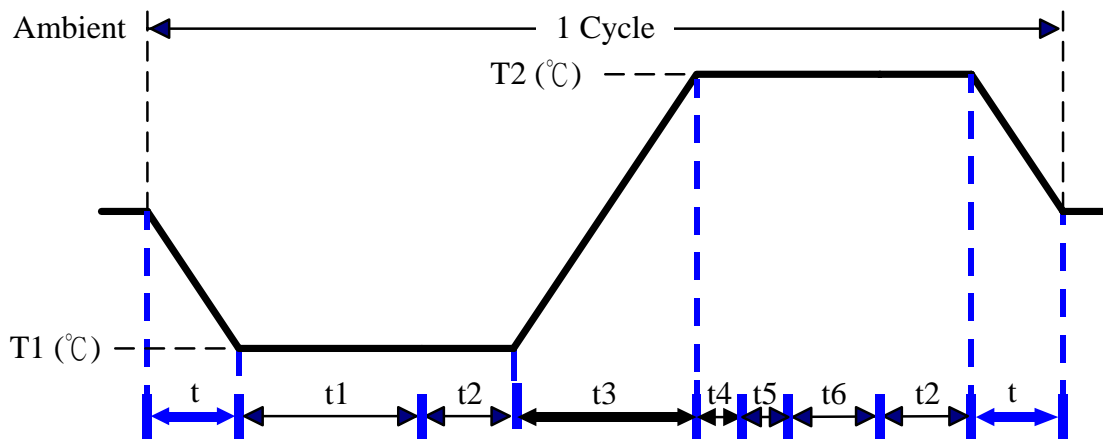
Test Product: GCS-1100I

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4L+-100
Date of Calibration: 05/06/10
Serial Number: 1241

Test Condition:



Parameters	Description
T1	-5°C
T2	50°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temprature slope
t , t1, t6: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3, t4: Run PassMark Burn In Test
t5: Win XP Software restart test 3 times
Test Software: Windows XP

Test Result:

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.